

Notice of References Cited	Application/Control No. 10/707,223		Applicant(s)/Patent Under Reexamination YEN ET AL.	
	Examiner MUHAMMAD N. EDUN		Art Unit 2627	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,785,204	08-2004	Okuyama et al.	369/44.32
*	B	US-6,693,861	02-2004	Lim, Jae Cheol	369/44.28
*	C	US-6,408,285	06-2002	Oshima et al.	705/57
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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